













CSD18531Q5A

SLPS321E -JUNE 2012-REVISED AUGUST 2015

CSD18531Q5A 60 V N-Channel NexFET™ Power MOSFET

Features

- Ultra-Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Logic Level
- Pb Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5 mm x 6 mm Plastic Package

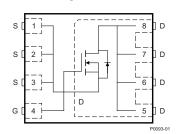
Applications

- DC-DC Conversion
- Secondary Side Synchronous Rectifier
- **Battery Motor Control**

3 Description

This 60-V, 3.5-m Ω , 5 mm × 6 mm NexFETTM power MOSFET is designed to minimize losses in power conversion applications.

TOP VIEW



R_{DS(on)} vs V_{GS} 12 $T_C = 25^{\circ}C$, $I_D = 22 A$ $T_C = 125^{\circ}C$, $I_D = 22 A$ R_{DS(on)} - On-State Resistance (mΩ) 10 8 0 0 2 20 V_{GS} - Gate-to-Source Voltage (V)

Product Summary

$T_A = 25^\circ$	С	TYPICAL VA	UNIT	
V_{DS}	Drain-to-source voltage	60	V	
Q_g	Gate charge total (10 V)	36	nC	
Q_{gd}	Gate charge gate-to-drain	5.9	nC	
D	Drain-to-source on-resistance	V _{GS} = 4.5 V	4.4	mΩ
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = 10 V	3.5	mΩ
$V_{GS(th)}$	Threshold voltage	1.8	٧	

Ordering Information⁽¹⁾

DEVICE	QTY	MEDIA	PACKAGE	SHIP
CSD18531Q5A	2500	13-Inch Reel	SON 5 mm ×	Tape
CSD18531Q5AT	250	7-Inch Reel	6 mm Plastic Package	and Reel

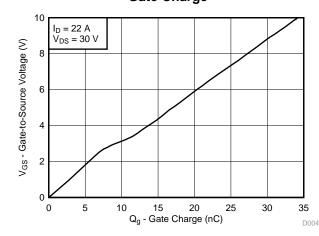
(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT	
V_{DS}	Drain-to-source voltage	60	V	
V_{GS}	Gate-to-source voltage	±20	V	
	Continuous drain current (package limited)	100		
I _D	Continuous drain current (silicon limited), T _C = 25°C	134	Α	
	Continuous drain current (1)	19		
I_{DM}	Pulsed drain current (2)	370	Α	
п	Power dissipation ⁽¹⁾	3.1	W	
P_D	Power dissipation, T _C = 25°C	156	VV	
TJ	Operating junction	-55 to 150	°C	
T _{stg}	Storage temperature	-55 to 150	°C	
E _{AS}	Avalanche energy, single pulse I_D = 67 A, L = 0.1 mH, R_G = 25 Ω	224	mJ	

- (1) Typical $R_{\theta JA} = 40^{\circ} \text{C/W}$ on a 1 inch², 2 oz. Cu pad on a 0.06 inch thick FR4 PCB.
- (2) Max R_{θJC} = 1°C/W, pulse duration ≤100 μs, duty cycle ≤1%

Gate Charge





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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Cr	ranges from Revision D (May 2015) to Revision E Page
•	Corrected device size in description from m to mm1
•	Corrected package type to SON
Cŀ	anges from Revision C (March 2015) to Revision D Page
•	Added Community Resources
Cŀ	anges from Revision B (October 2012) to Revision C Page
•	Added part number to title
•	Changed Q _g value to 36 nC, measured at 10 V
•	Added 7" reel to Ordering Information
•	Increase max pulsed current to 370 A
•	Added line for max power dissipation with the case temperature held to 25°C
•	Updated pulsed current conditions
•	Updated Figure 1 to show Z _{e,JC} curves
•	Updated Figure 10
•	Updated Figure 12
Cŀ	anges from Revision A (June 2012) to Revision B Page
•	Changed the Transconductance TYP value From: 177 S To: 128 S
•	Changed the Turn On and Turn Off Delay Time, Rise and Fall Time Test Conditions From: I_{DS} = 22 A, R_{G} = 2 Ω To: I_{DS} = 22 A, R_{G} = 0 Ω
•	Changed the Q _{rr} Reverse Recovery Charge TYP value From: 68 nC To: 100 nC
Ch	anges from Original (June 2012) to Revision A Page
•	Added T _∧ = 25°C to the Product Summary table

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5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS				
BV _{DSS}	Drain-to-source voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60		V
I _{DSS}	Drain-to-source leakage current	$V_{GS} = 0 \text{ V}, V_{DS} = 48 \text{ V}$		1	μΑ
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = 20 V		100	nA
$V_{GS(th)}$	Gate-to-source threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.5 1.8	2.3	V
D	Drain-to-source on-resistance	$V_{GS} = 4.5 \text{ V}, I_D = 22 \text{ A}$	4.4	5.8	$m\Omega$
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = 10 V, I _D = 22 A	3.5	4.6	$m\Omega$
9 _{fs}	Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 22 \text{ A}$	128		S
DYNAMI	C CHARACTERISTICS				
C _{iss}	Input capacitance		3200	3840	pF
C _{oss}	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$	380	456	pF
C _{rss}	Reverse transfer capacitance		11	14	pF
R _G	Series gate resistance		1.2	2.4	Ω
Qg	Gate charge total (4.5 V)		18	22	
Qg	Gate charge total (10 V)		36	43	nC
Q _{gd}	Gate charge gate-to-drain	V _{DS} = 30 V, I _D = 22 A	5.9		nC
Q _{gs}	Gate charge gate-to-source		6.9		nC
Q _{g(th)}	Gate charge at V _{th}		5.2		nC
Q _{oss}	Output charge	V _{DS} = 30 V, V _{GS} = 0 V	32		nC
t _{d(on)}	Turn on delay time		4.4		ns
t _r	Rise time	V _{DS} = 30 V, V _{GS} = 10 V,	7.8		ns
t _{d(off)}	Turn off delay time	I_{DS} = 22 A, R_G = 0 Ω	20		ns
t _f	Fall time		2.7		ns
DIODE C	CHARACTERISTICS			'	
V_{SD}	Diode forward voltage	I _{SD} = 22 A, V _{GS} = 0 V	0.8	1	V
Q _{rr}	Reverse recovery charge	V _{DS} = 30 V, I _F = 22 A,	100		nC
t _{rr}	Reverse recovery time	di/dt = 300 A/µs	40		ns

5.2 Thermal Information

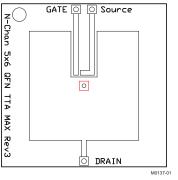
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance ⁽¹⁾			1.0	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾⁽²⁾			50	°C/W

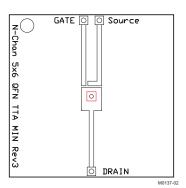
 $R_{\theta JC}$ is determined with the device mounted on a 1 inch² (6.45 cm²), 2 oz. (0.071 mm thick) Cu pad on a 1.5 inch × 1.5 inch (3.81 cm × 3.81 cm), 0.06 inch (1.52 mm) thick FR4 PCB. $R_{\theta JC}$ is specified by design, whereas $R_{\theta JA}$ is determined by the user's board design. Device mounted on FR4 material with 1 inch² (6.45 cm²), 2 oz. (0.071 mm thick) Cu.

Product Folder Links: CSD18531Q5A





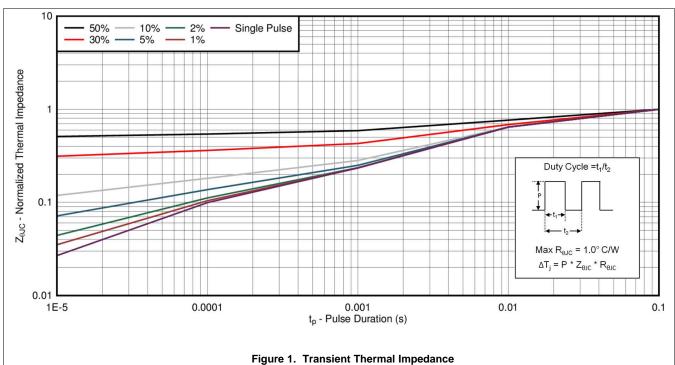
Max $R_{\theta JA} = 50^{\circ}C/W$ when mounted on 1 inch2 (6.45 cm2) of 2 oz. (0.071 mm thick) Cu.



Max $R_{\theta JA} = 125$ °C/W when mounted on a minimum pad area of 2 oz. (0.071 mm thick) Cu.

5.3 Typical MOSFET Characteristics

(T_A = 25°C unless otherwise stated)



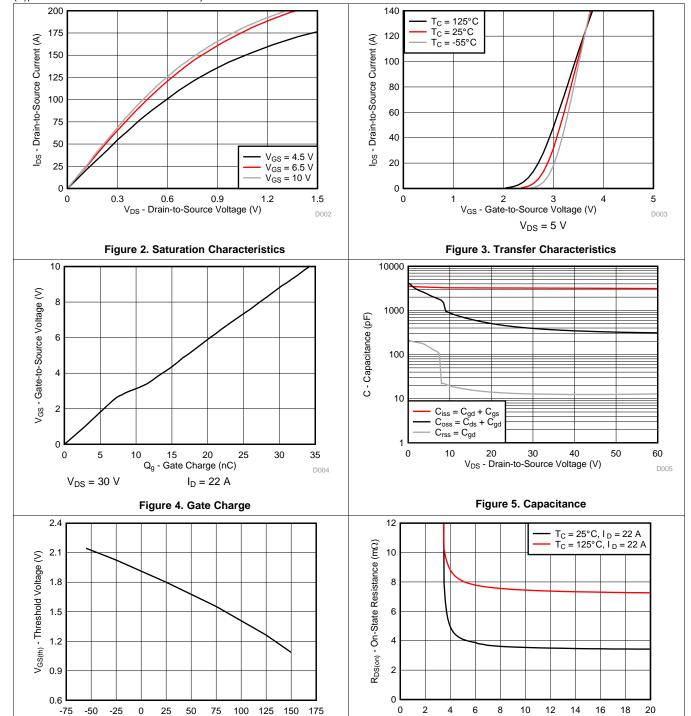
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Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)



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T_C - Case Temperature (°C)

 $I_D = 250 \ \mu A$

Figure 6. Threshold Voltage vs Temperature

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V_{GS} - Gate-to-Source Voltage (V)

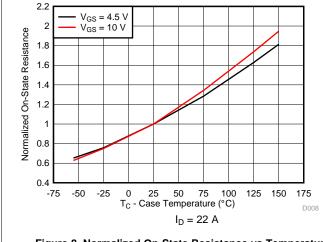
Figure 7. On-State Resistance vs Gate-to-Source Voltage

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Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)



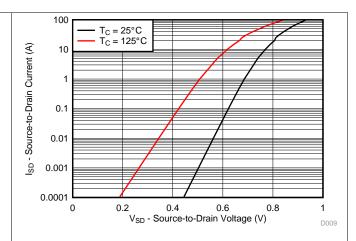
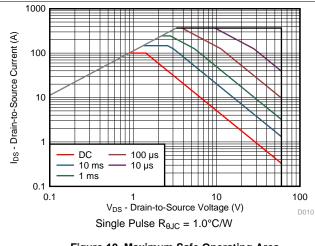


Figure 8. Normalized On-State Resistance vs Temperature





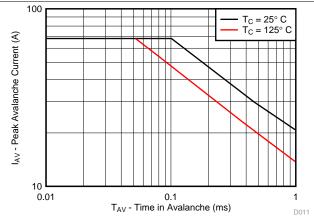


Figure 10. Maximum Safe Operating Area

Figure 11. Single Pulse Unclamped Inductive Switching

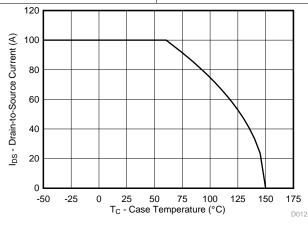


Figure 12. Maximum Drain Current vs Temperature

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6 Device and Documentation Support

6.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

6.2 Trademarks

NexFET, E2E are trademarks of Texas Instruments.

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6.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

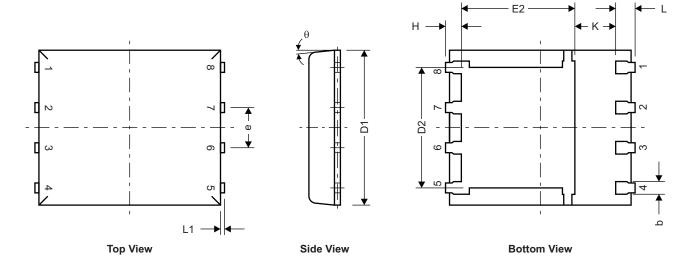
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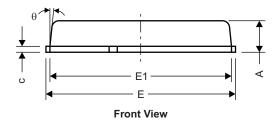


7 Mechanical Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Q5A Package Dimensions



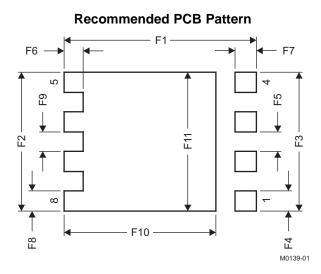


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DIM		MILLIMETERS	
DIM	MIN	NOM	MAX
А	0.90	1.00	1.10
b	0.33	0.41	0.51
С	0.20	0.25	0.34
D1	4.80	4.90	5.00
D2	3.61	3.81	4.02
Е	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
е	1.17	1.27	1.37
Н	0.41	0.56	0.71
К	1.10		
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
θ	0°		12°

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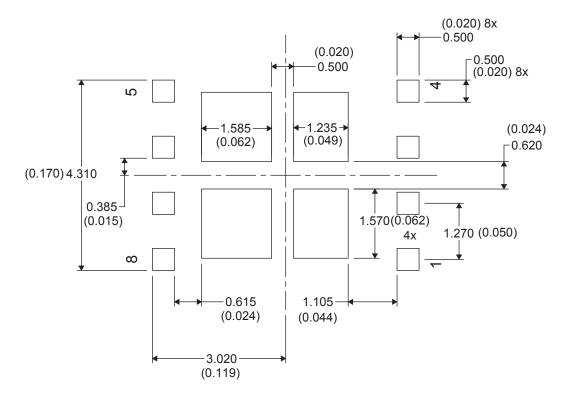




DIM	MILLIME	TERS	INCH	IES
DIIVI	MIN	MAX	MIN	MAX
F1	6.205	6.305	0.244	0.248
F2	4.46	4.56	0.176	0.18
F3	4.46	4.56	0.176	0.18
F4	0.65	0.7	0.026	0.028
F5	0.62	0.67	0.024	0.026
F6	0.63	0.68	0.025	0.027
F7	0.7	8.0	0.028	0.031
F8	0.65	0.7	0.026	0.028
F9	0.62	0.67	0.024	0.026
F10	4.9	5	0.193	0.197
F11	4.46	4.56	0.176	0.18

For recommended circuit layout for PCB designs, see application note *Reducing Ringing Through PCB Layout Techniques*, SLPA005.

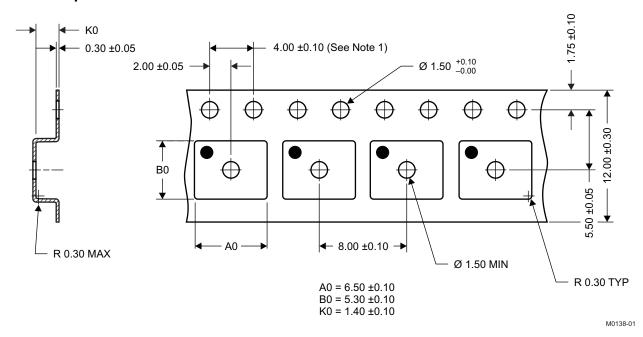
7.2 Recommended Stencil Opening



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7.3 Q5A Tape and Reel Information



Notes:

- 1. 10 sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket

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PACKAGE OPTION ADDENDUM

24-Jul-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD18531Q5A	ACTIVE	VSONP	DQJ	8	2500	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD18531	Samples
CSD18531Q5AT	ACTIVE	VSONP	DQJ	8	250	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM		CSD18531	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

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